

TACS



Three Omega Characterization System

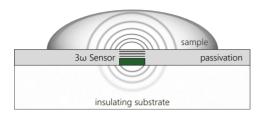
Thermal conductivity characterization done within a minute

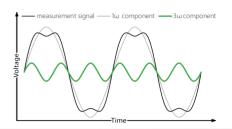
A straightforward solution. From solids to liquids.

TOCS is a compact quick testing system for characterization of a wide range of various materials to obtain both, the thermal conductivity and diffusivity, within a few minutes.

- Liquids and suspensions
- ▶ Gels, pastes and filled greases
- Pads and soft materials
- Compact benchtop system
- ▶ Re-usable test chips
- ▶ External sample holder
- ▶ Complete hard- and software solution
- Compatible with any other 3-omega measurement structure

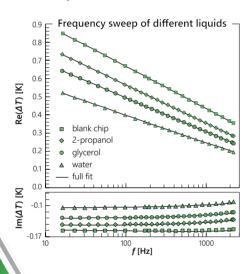






Thermal conductivity and diffusivity

The bi-directional model fit of 3-omega method simultaneously provides thermal conductivity and diffusivity of the tested material. Thermal conductivity, in particular, is available within a minute.



- ▶ All-in-one software suite
- Very fast measurement with high reproducability
- Easy sample application
- Curing and non-curing materials
- Measurement in applicationspecific environment:
 - Vacuum or protective gas
 - ▶ Elevated temperatures
 - ▶ High atmospheric pressure





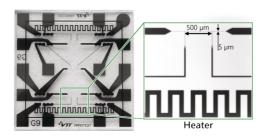
Your system, your rules

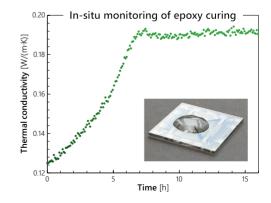
TOCS supports the use of any 3-omega structure as plug and play. Out of the box.

But if you don't have your own chips at hand, do not dispair. We have the right one for you.

Chip characteristics

- Borosilicate glass chips
- ▶ 12 x 12 mm² size
- ▶ Three 3-omega sensors
- Two independent heaters
- ▶ Low-budget consumable









Description

TOCS® is a compact quick-testing benchtop system for characterization of a wide range of various materials to obtain both, the thermal conductivity and diffusivity, within few minutes.

Technical Specification

System

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System type	Benchtop material characterization system		
Footprint (w × d)	54 × 40	cm ²	
Height	17	cm	
Weight	12	kg	
Power supply	230 / 50 / 100	VAC / Hz / W	

Measurement conditions		Default chip stage		Heatable chip stage		
		min	max	min	max	
Freitation frances	single channel	10	40 000	10	40 000	Hz
Excitation frequency	triple channel	10	12 000	10	12 000	Hz
C	Chip stage in temperature chamber	-10	80	-10	80	°C
Sample temperature	Heating by chip stage	no h	neating	250		°C

no heating

Measurement

Heating rate

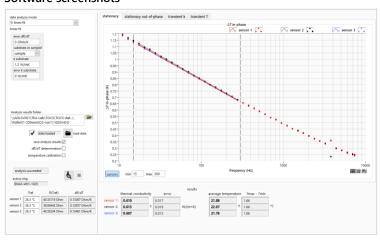
Methodology	bi-directional 3ω (three-omega) method	
Output	Thermal conductivity	W/(m⋅K)
	Thermal diffusivity	m²/s
Resolution	0.01	cm ² K/W

Sample properties	min	max	
Size (round, diameter)	1	8	mm
Thickness	0.01		mm
Thermal conductivity	0.05	500	W/(m⋅K)
Thermal diffusivity	0.1	100 000	$10^{-9} \text{ m}^2/\text{s}$

Measurement accuracy

Thermal conductivitiy	± 1	%
Thermal diffusivity	± 5	%

Software screenshots



Key features

- » Quick measurement
- » Compact and all-in-one
- » Re-usable & disposable test chips
- » External & movable chip stage
- » Compatibility with any arbitrary 3-omega measurement structure

60

K/min

Key output material and compound properties

- » Thermal conductivity
- » Thermal diffusivity

Key testing schemes

- » Quick test series
- » Regular quality screening
- » Temperature dependency
- » Process structure property correlation
- » In-situ curing monitoring
- » In-situ aging investigation

Scope of samples

- » Low to high viscous material
- » Polymers
- » Thermal interface material
- » Pastes and greases
- » Gap pads and gap filler
- » Adhesive and cured material
- » Mold compound & underfiller